

Title (en)

Method of analysing an electronic device

Title (de)

Verfahren zur Untersuchung eines elektronischen Geräts

Title (fr)

Procédé d'analyse d'un dispositif électronique

Publication

EP 2810219 B1 20190612 (EN)

Application

EP 13744249 A 20130130

Priority

- US 201261593358 P 20120201
- US 201261607548 P 20120306
- US 201261607572 P 20120306
- US 2013023717 W 20130130

Abstract (en)

[origin: EP3620974A1] A recycling kiosk (100) for recycling and financial remuneration for submission of an electronic device (150) is disclosed herein. The recycling kiosk (100) includes an inspection area (106) with preferably two mirrored, domed hemispheres positioned about a transparent table and cameras for imaging an electronic device (15) placed on the table. The recycling kiosk (150) uses visual analysis to identify an electronic device (150), determine the condition of the electronic device (150) and determine if the electronic device (150) is authentic.

IPC 8 full level

G06T 1/00 (2006.01); **G06T 7/00** (2017.01); **G06V 10/141** (2022.01); **G07F 7/06** (2006.01)

CPC (source: EP US)

G06Q 20/18 (2013.01 - EP); **G06Q 20/322** (2013.01 - EP); **G06V 10/141** (2022.01 - EP US); **G06V 10/469** (2022.01 - EP);
G06V 10/54 (2022.01 - EP); **G07F 7/06** (2013.01 - EP US); **G06V 2201/06** (2022.01 - EP)

Cited by

CN113405994A; CN112581001A; US11989710B2; WO2023235821A1; US11935138B2; WO2020167846A1

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DOCDB simple family (publication)

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